

Application/Control No.	Applicant(s)/Patent under Reexamination BISGAARD-FRANTZEN ET AL.	
10/520,956		
Examiner	Art Unit	
Taeyoon Kim	1651	

SEARCHED				
Subclass	Date	Examiner		
	Subclass	Subclass Date		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST search (USPG- pub;USPAT;USOCR;EPO;JPO;Derwe nt)	9/29/2006	тк		
Inventor search (PALM/EAST)	9/29/2006	тк		
Updated search (EAST)	5/10/2007	ТК		
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